

GENERAL DESCRIPTION

The ME2N7002D is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density , DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits where high-side switching , and low in-line power loss are needed in a very small outline surface mount package.

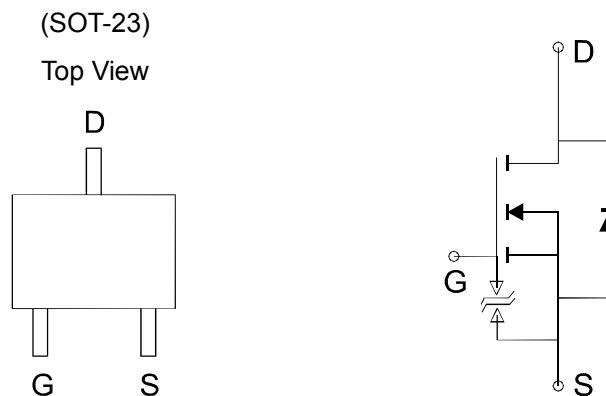
FEATURES

- Simple Drive Requirement
- Small Package Outline
- ROHS Compliant
- ESD Rating = 2000V HBM

Mechanical data

- High density cell design for low $R_{DS(ON)}$
- Voltage controlled small signal switching.
- Rugged and reliable.
- High saturation current capability.
- High-speed switching.
- Not thermal runaway.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.

PIN CONFIGURATION



Absolute Maximum Ratings (TA=25°C Unless Otherwise Noted)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current	I_D	300	mA
Pulsed Drain Current (Note 1)	I_{DM}	2000	mA
Maximum Power Dissipation	$P_D @T_A=25^\circ C$	0.35	W
	$P_D @T_A=75^\circ C$	0.21	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 ~ 150	°C
Junction-to-Ambient Thermal Resistance (PCB mounted) (Note 2)	$R_{\theta JA}$	357	°C/W



Electrical Characteristics (TA=25°C Unless Otherwise Specified)

Symbol	Parameter	Limit	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0, I _D =10uA	60	-	-	V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1.0	-	2.5	V
g _{fs}	Forward Transconductance	V _{DS} =15V, I _D =250mA	100	-	-	mS
I _{GSS}	Gate Body Leakage	V _{GS} = ±20V, V _{DS} =0V	-	-	±10	uA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V	-	-	1	uA
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =10V, I _D =500mA	-	-	3	Ω
		V _{GS} =4.5V, I _D =200mA	-	-	4	
Dynamic						
Q _g	Total Gate Charge	I _D =200mA, V _{DS} =15V V _{GS} =4.5V	-	-	0.8	nC
T _{d(on)}	Turn-on Time	V _{DD} =30V, R _L =150Ω, I _D =200mA, V _{GEN} =10V	-	-	20	nS
T _{d(off)}	Turn-off Time	R _G =10Ω	-	-	40	
C _{iss}	Input Capacitance	V _{GS} =0V	-	-	35	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	-	10	
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	-	5	

Source-Drain Diode

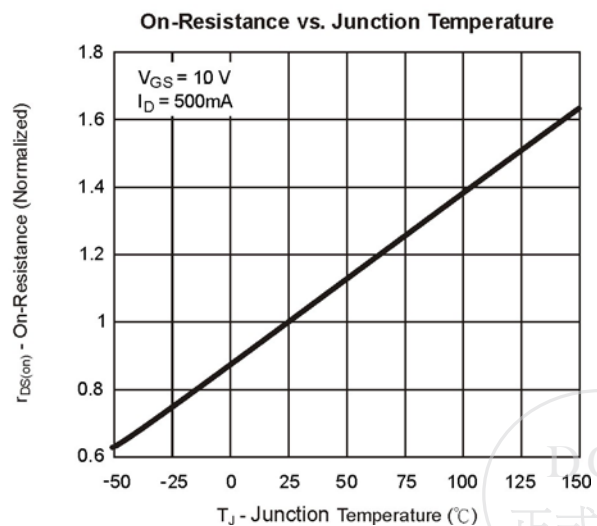
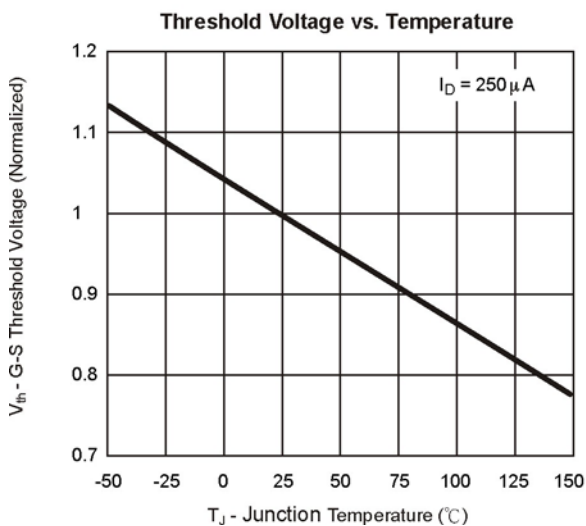
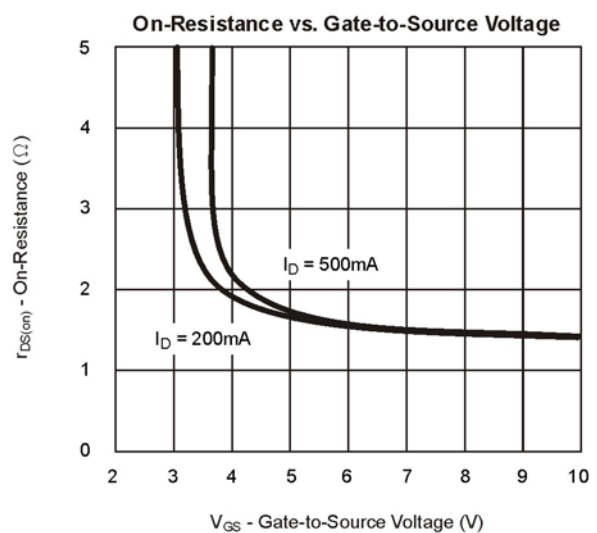
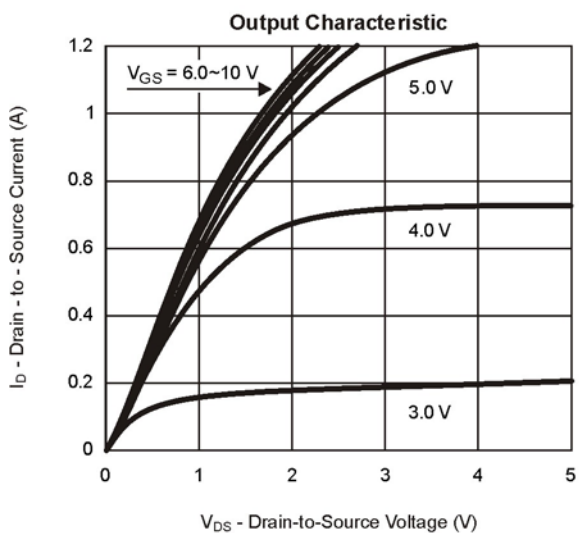
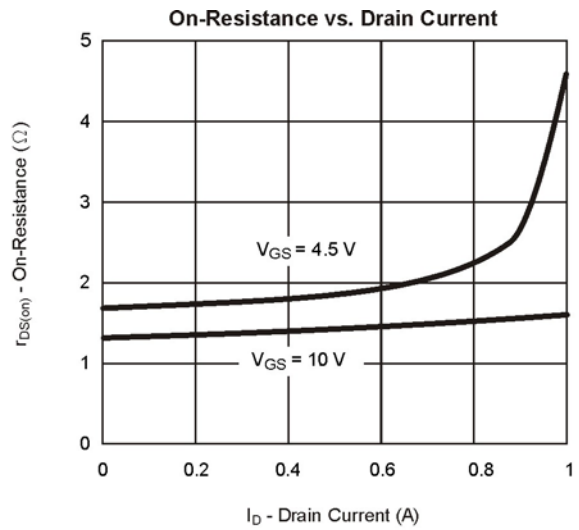
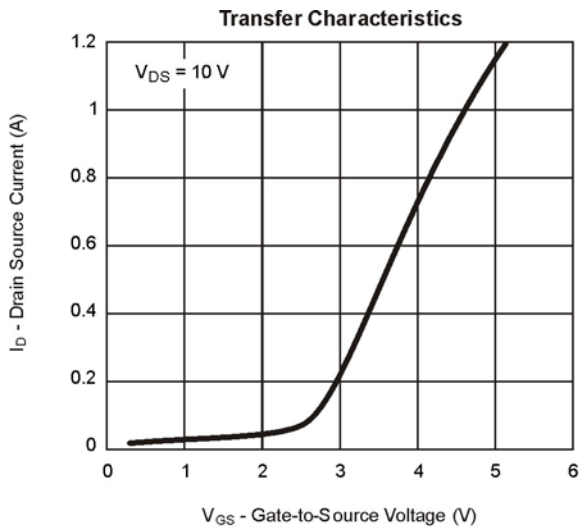
Symbol	Parameter	Limit	Min.	Typ.	Max.	Unit
V _{SD}	Diode Forward Voltage	I _S =200mA, V _{GS} =0V	-	0.82	1.3	V

Notes :

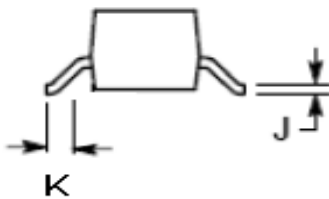
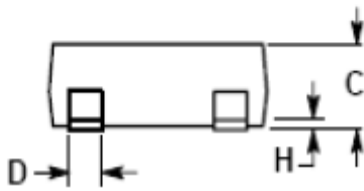
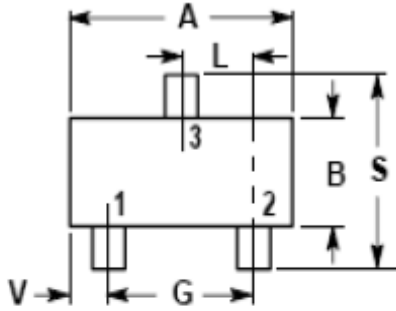
1. Maximum DC current limited by the package
2. Surface mounted on FR4 board, t ≤ 5sec.



Typical Characteristics (T_J = 25°C Noted)



SOT-23 Package Outline

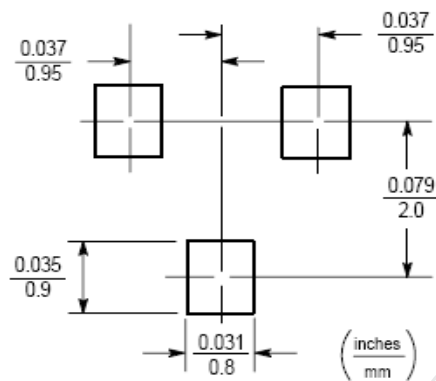


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.1102	0.1197	2.80	3.04
B	0.0472	0.0551	1.20	1.40
C	0.0350	0.0440	0.89	1.11
D	0.0150	0.0200	0.37	0.5
G	0.0701	0.0807	1.78	2.04
H	0.0005	0.0040	0.013	0.100
J	0.0034	0.0070	0.085	0.177
K	0.007	—	0.018	—
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.1039	2.10	2.64
V	0.0177	0.0236	0.45	0.60

SOLDERING FOOTPRINT*

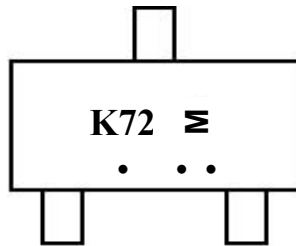


N-Channel MOSFET – ESD Protected

Device name:ME2N7002D-G

Package:SOT-23

Marking Code:



K72: Device Marking Code

M: Date code

MONTH CODE

ODD YEARS(2007,2009)

Jan	1
Feb	2
Mar	3
Apr	4
May	5
Jun	6
Jul	7
Aug	8
Sep	9
Oct	T
Nov	V
Dec	C

EVEN YEARS(2006,2008)

Jan	E
Feb	F
Mar	H
Apr	J
May	K
Jun	L
Jul	N
Aug	P
Sep	U
Oct	X
Nov	Y
Dec	Z

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